Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/520,413	DEPAUW ET AL.
Examiner	Art Unit
Alain L. Bashore	1762

Alain L. Bashore

SEARCHED					
Class	Subclass	Date	Examiner		
427	162, 165, 166, 168	4/27/2007	АВ		
428	432, 341	4/27/2007	ab		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
inventor search	4/27/2007	АВ		
East (orthochod)	4-27-07	9R		
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